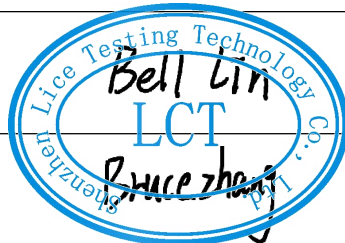




EMC Test Report

Report Number.....:	LCT-250103010327	
Applicant's name.....:	Shenzhen KeepTeen Electronic Technology Co., Ltd.	
Address.....:	Room 502,5th Floor, No.1 Longtang Industrial Zone,Henggang Street, Longgang District, Shenzhen	
Equipment Under Test (EUT)		
EUT Name.....:	Solar Charger	
Model No.....:	D5	
Serial No.....:	D5-L, K5, K7	
Brand Name.....:	N/A	
Testing Laboratory.....:	Shenzhen Lice Testing Technology Co., Ltd. Room 112-113, Building B15, Yintian Industrial Zone, Yantian, Xixiang Street, Bao'an District, Shenzhen, Guangdong, China	
Standards.....:	EN 55032: 2015/A1: 2020 EN 55035:2017/A11:2020	
Directive.....:	EMC Directive 2014/30/EU	
Conclusions.....:	PASS	
Receipt Date.....:	2025-01-16	
Test Date.....:	2025-01-16 to 2025-01-19	
Issue Date.....:	2025-01-19	
Test/Witness Engineer.....:	Bell Lin	
Approved & Authorized.....:	Bruce Zhang	

The test results of this report relate only to the tested sample identified in this report. This report shall not be reproduced, except in full, without the written approval of the Issuing Testing Laboratory.

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1. General Information

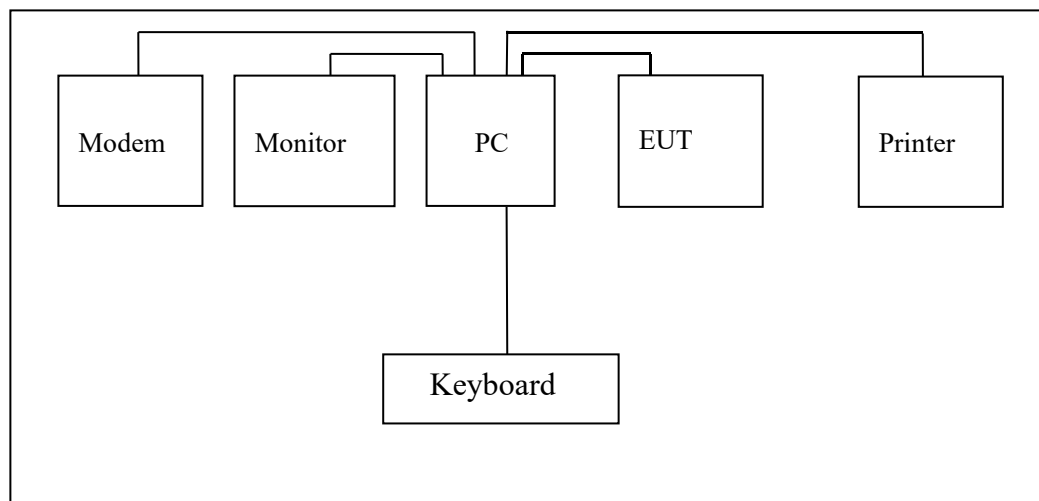
1.1. Client Information

Applicant	:	Shenzhen KeepTeen Electronic Technology Co., Ltd.
Address	:	Room 502,5th Floor, No.1 Longtang Industrial Zone,Henggang Street, Longgang District, Shenzhen
Manufacturer	:	Shenzhen KeepTeen Electronic Technology Co., Ltd.
Address	:	Room 502,5th Floor, No.1 Longtang Industrial Zone,Henggang Street, Longgang District, Shenzhen

1.2. General Description of EUT (Equipment Under Test)

EUT Name	:	Solar Charger
Model No.	:	D5
Serial No.	:	D5-L, K5, K7
Brand Name	:	N/A
Power Supply	:	DC 5V, 3A
Remark: All above models are identical in schematic, structure and critical components except for only different model name; therefore, EMC testing was performed with D5 only.		

1.3. Block Diagram Showing The Configuration of System Tested



1.4. Description of Support Units

Name	Model	S/N	Manufacturer	Used “√”
Printer	HP1505n	VNF3G06957	HP	√
Modem	RX304Xv2	----	ASUS	√
LCD Monitor	E170Sc	----	DELL	√
PC	OPTIPLEX380	----	DELL	√
Keyboard	L100	U01C	DELL	√

1.5. Performance Criterion

Criterion A: The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended.

Criterion B: After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended.

Criterion C: Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions.

1.6. Test Facility

The testing report were performed by the Shenzhen Lice Testing Technology Co., Ltd., in their facilities located at Room 112-113, Building B15, Yintian Industrial Zone, Yantian, Xixiang Street, Bao'an District, Shenzhen, Guangdong, China.

2. TEST Results Summary

EMISSION		
Description of test items	Standards	Results
Conducted disturbance at mains terminals	EN 55032: 2015/A1: 2020	N/A
Radiated Disturbance	EN 55032: 2015/A1: 2020	Pass
Harmonic current emissions	EN IEC 61000-3-2: 2019/A1: 2021	N/A
Voltage fluctuation and flicker	EN 61000-3-3:2013/A2:2021	N/A
IMMUNITY		
Description of test items	Standards	Results
Electrostatic Discharge (ESD)	EN 61000-4-2: 2009	Pass
Radio-frequency, Continuous radiated disturbance	EN IEC 61000-4-3:2020	Pass
EFT/B Immunity	EN 61000-4-4: 2012	N/A
Surge Immunity	EN 61000-4-5: 2014/A1:2017	N/A
Conducted RF Immunity	EN 61000-4-6: 2014	N/A
Power frequency magnetic field	EN 61000-4-8: 2010	N/A
Voltage dips, >95% reduction	EN IEC 61000-4-11:2020	N/A
Voltage dips, 30% reduction		
Voltage interruptions		
Note: N/A is an abbreviation for Not Applicable.		

3. Test Equipment Used

3.1. Test Equipment Used to Measure Conducted Emission					
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
LCT-EMC001	EMI Test Receiver	Rohde & Schwarz	ESCS30	Dec. 28, 2024	1 Year
LCT-EMC002	AMN	Rohde & Schwarz	ENV216	Dec. 28, 2024	1 Year
LCT-EMC003	AMN	SCHWARZBECK	NNBL 8226	Dec. 28, 2024	1 Year
3.2. Test Equipment Used to Measure Radiated Emission					
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
LCT-EMC004	EMI Test Receiver	Rohde & Schwarz	ESI26	Dec. 28, 2024	1 Year
LCT-EMC005	Bilog Antenna	SCHWARZBECK	VULB9163	Dec. 28, 2024	1 Year
LCT-EMC006	Positioning Controller	C&C	CC-C-1F	N/A	N/A
3.3. Test Equipment Used to Measure Harmonic Current/ Voltage Fluctuation and Flicker					
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
LCT-EMC007	Harmonic Flicker Test System	CI	5001ix-CTS-400	Dec. 28, 2024	1 Year
3.4. Test Equipment Used to Measure Electrostatic Discharge Immunity					
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
LCT-EMC008	ESD Tester	TESEQ	NSG437	Dec. 28, 2024	1 Year
3.5. Test Equipment Used to Measure Conducted Immunity					
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
LCT-EMC009	RF Generator	FRANKONIA	CIT-10/75	Dec. 28, 2024	1 Year
LCT-EMC010	Attenuator	FRANKONIA	59-6-33	Dec. 28, 2024	1 Year
LCT-EMC011	M-CDN	LUTHI	M2/M3	Dec. 28, 2024	1 Year
LCT-EMC012	CDN	LUTHI	AF2	Dec. 28, 2024	1 Year
LCT-EMC013	EM Injection Clamp	LUTHI	EM101	Dec. 28, 2024	1 Year
3.6. Test Equipment Used to Measure Radio Frequency Electromagnetic Fields Immunity					
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
LCT-EMC014	Signal Generator	Rohde & Schwarz	SMT03	Dec. 28, 2024	1 Year

LCT-EMC015	Power Meter	Rohde & Schwarz	NRVD	Dec. 28, 2024	1 Year
LCT-EMC016	Voltage Probe	Rohde & Schwarz	URV5-Z2	Dec. 28, 2024	1 Year
LCT-EMC017	Voltage Probe	Rohde & Schwarz	URV5-Z2	Dec. 28, 2024	1 Year
LCT-EMC018	Power Amplifier	AR	150W1000	Dec. 28, 2024	1 Year
LCT-EMC019	Bilog Antenna	Chase	CBL6111C	Dec. 28, 2024	1 Year

3.7. Test Equipment Used to Measure Electrical Fast Transient/Burst Immunity

No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
LCT-EMC020	Simulator	EMTEST	UCS500N5	Dec. 28, 2024	1 Year
LCT-EMC021	Auto-transformer	EMTEST	V4780S2	Dec. 28, 2024	1 Year

3.8. Test Equipment Used to Measure Surge Immunity

No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
LCT-EMC022	Simulator	EMTEST	UCS500N5	Dec. 28, 2024	1 Year
LCT-EMC023	Coupling Clamp	EMTEST	HFK	Dec. 28, 2024	1 Year

3.9. Test Equipment Used to Measure Voltage Dips and Interruptions Immunity

No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
LCT-EMC022	Simulator	EMTEST	UCS500N5	Dec. 28, 2024	1 Year
LCT-EMC023	Coupling Clamp	EMTEST	HFK	Dec. 28, 2024	1 Year

3.10. Test Equipment Used to Measure Power frequency Magnetic Field

No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
LCT-EMC026	Power Frequency Magnetic Field Generator	EVERFINE	EMS61000-8	Dec. 28, 2024	1 Year

4. Conducted Emission Test

4.1. Test Standard and Limit

4.1.1. Test Standard

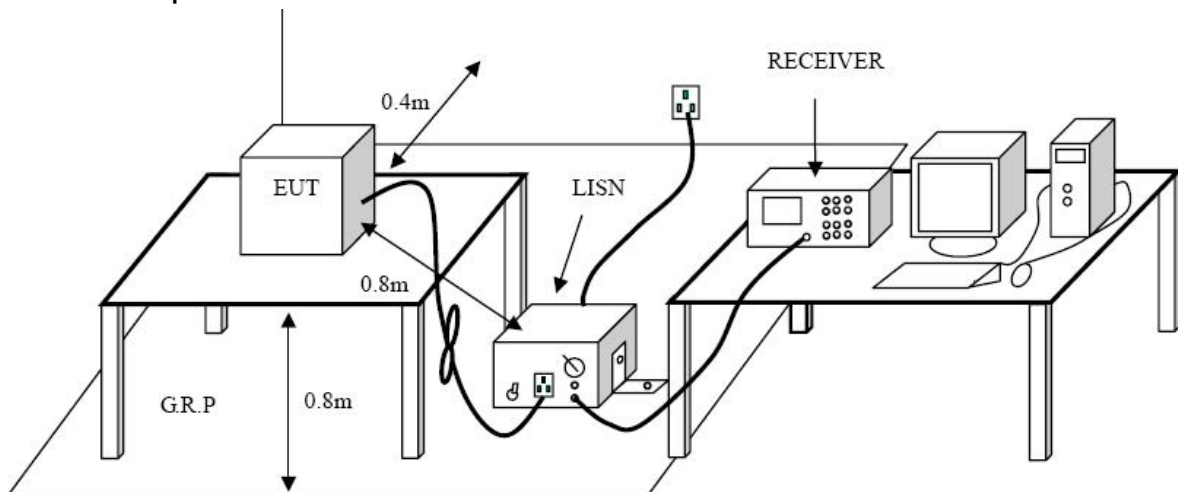
EN 55032: 2015/A1: 2020.

4.1.2. Test Limit

Conducted Disturbance Test Limit (Class B)

Frequency	Maximum RF Line Voltage (Db μ V)	
	Quasi-peak Level	Average Level
150kHz~500kHz	66 ~ 56 *	56 ~ 46 *
500kHz~5MHz	56	46
5MHz~30MHz	60	50

4.2. Test Setup



4.3. Test Procedure

The EUT was placed 0.8 meters from the horizontal ground plane with EUT being connected to the power mains through a line impedance stabilization network (LISN). All other support equipments powered from additional LISN(s). The LISN provide 50 Ohm/ 50Uh of coupling impedance for the measuring instrument.

Interconnecting cables that hang closer than 40 cm to the ground plane shall be folded back and forth in the center forming a bundle 30 to 40 cm long.

I/O cables that are not connected to a peripheral shall be bundled in the center. The end of the cable may be terminated, if required, using the correct terminating impedance. The overall length shall not exceed 1 m.

LISN at least 80 cm from nearest part of EUT chassis.

The bandwidth of EMI test receiver is set at 9kHz, and the test frequency band is from

0.15MHz to 30MHz.

4.4. Test Condition

Temperature	:	25 °C
Relative Humidity	:	48 %
Pressure	:	1010 hPa
Test Power	:	N/A

4.5. Test Data

5. Radiated Emission Test

5.1. Test Standard and Limit

5.1.1. Test Standard

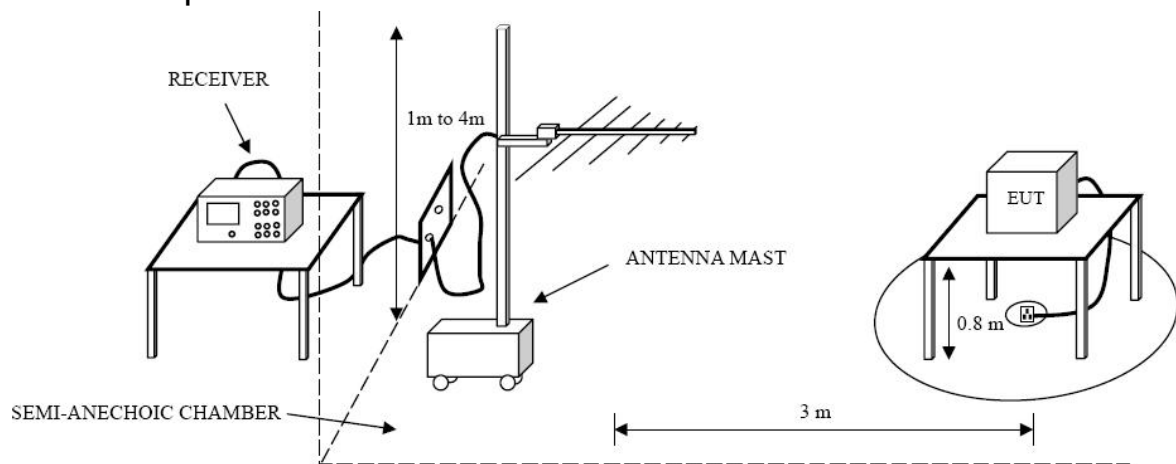
EN 55032: 2015/A1: 2020

5.1.2. Test Limit

Radiated Disturbance Test Limit (Class B)

Frequency	Limit (dB μ V/m)
	Quasi-peak Level
30MHz~230MHz	40
230MHz~1000MHz	47
Remark: 1. The lower limit shall apply at the transition frequency. 2. The test distance is 3m.	

5.2. Test Setup



5.3. Test Procedure

The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3m. The table was rotated 360 degrees to determine the position of the highest radiation.

The height of the equipment or of the substitution antenna shall be 0.8 m; the height of the test antenna shall vary between 1 m to 4 m. Both horizontal and vertical polarizations of the antenna are set to make the measurement.

The initial step in collecting radiated emission data is a spectrum analyzer peak detector mode pre-scanning the measurement frequency range.

If the Peak Mode measured value compliance with and lower than Quasi Peak Mode Limit, the EUT shall be deemed to meet QP Limits and then no additional QP Mode measurement performed.

5.4. Test Condition

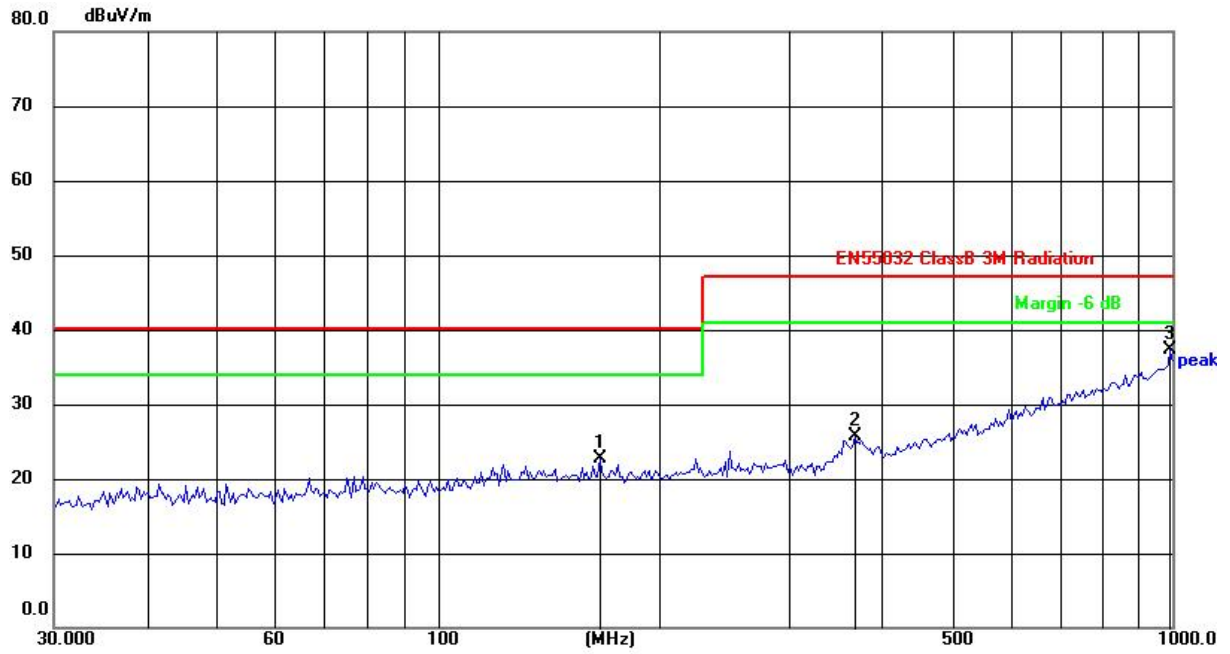
Temperature	:	25 °C
Relative Humidity	:	48 %
Pressure	:	1010 hPa
Test Power	:	DC 5V

5.5. Test Data

Please refer to the following pages.

Operating Condition: Normal

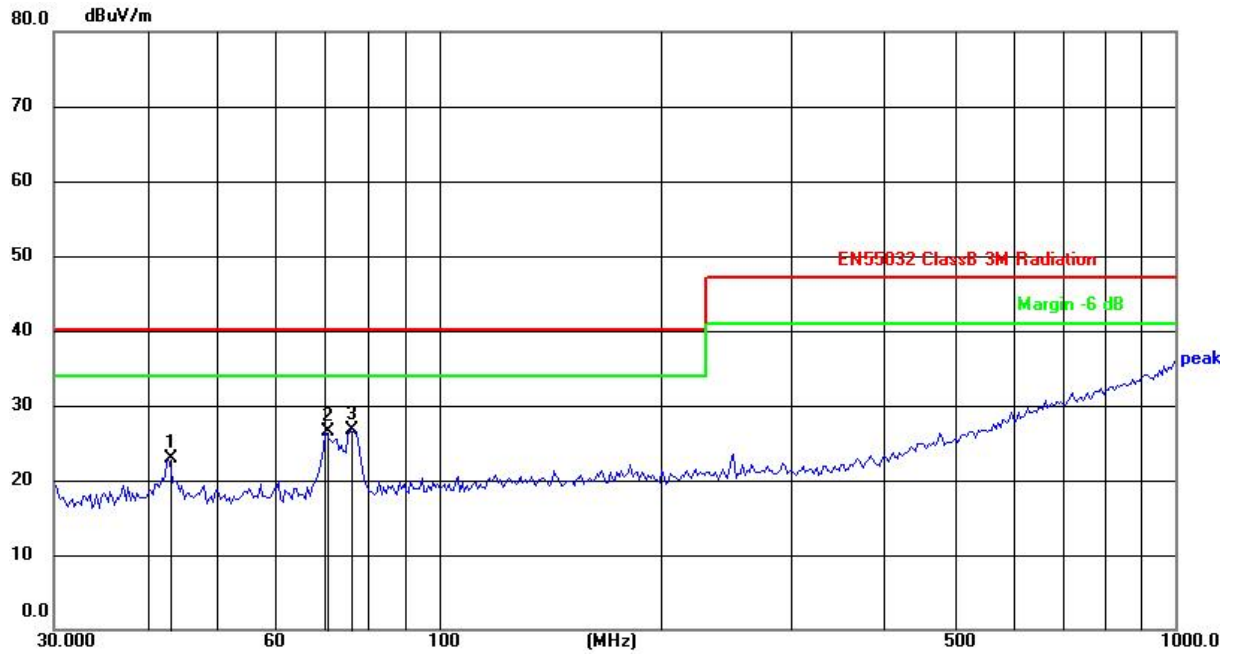
Test Specification: Horizontal



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	Height (cm)	Azimuth (deg.)	P/F	Remark
1	166.0680	40.99	-18.38	22.61	40.00	-17.39	peak				
2	369.4047	42.65	-16.93	25.72	47.00	-21.28	peak				
3	993.0114	42.75	-5.52	37.23	47.00	-9.77	peak				

Operating Condition: Normal

Test Specification: Vertical



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	Height (cm)	Azimuth (deg.)	P/F	Remark
1	42.8998	43.78	-20.79	22.99	40.00	-17.01	peak				
2	70.0903	47.03	-20.55	26.48	40.00	-13.52	peak				
3	75.7114	47.12	-20.39	26.73	40.00	-13.27	peak				

6. Electrostatic Discharge Immunity Test

6.1. Test Requirements

6.1.1. Test Standard

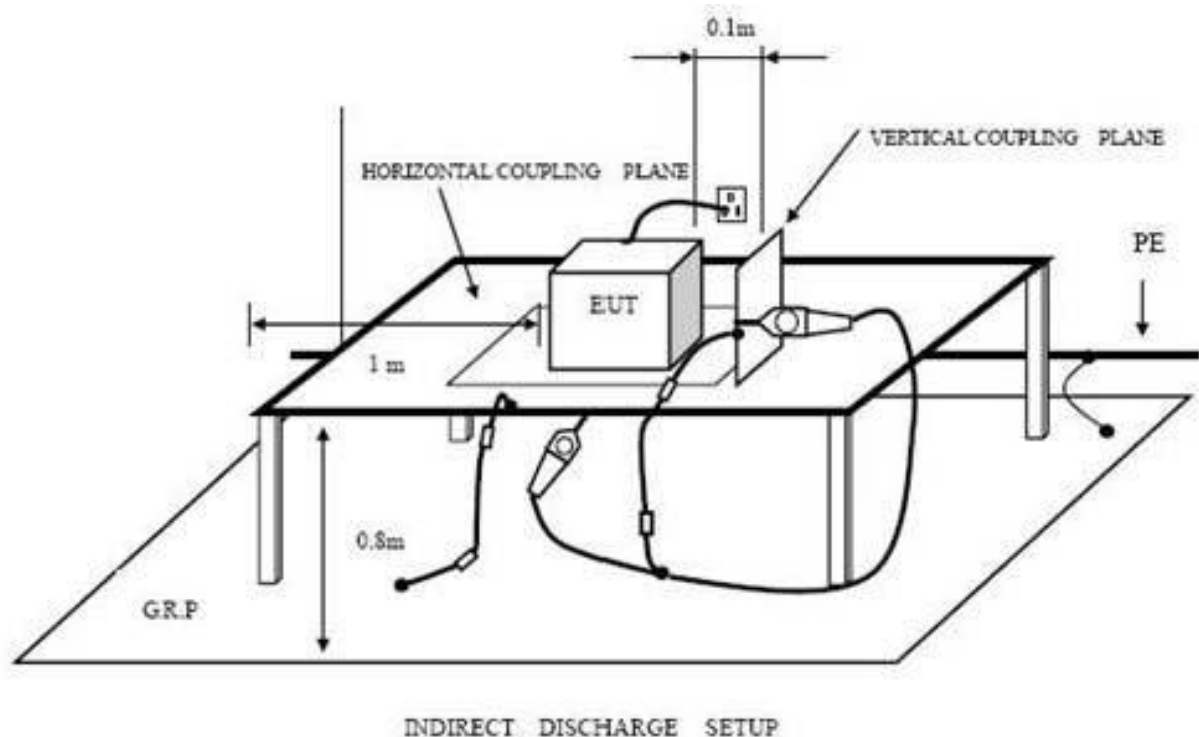
EN 55035:2017/A11:2020 (EN 61000-4-2: 2009)

6.1.2. Test Level

Level	Test Voltage Contact Discharge (kV)	Test Voltage Air Discharge (kV)
1	±2	±2
2	±4	±4
3	±6	±8
4	±8	±15
X	Special	Special

6.1.3. Performance criterion: **B**

6.2. Test Setup



6.3. Test Procedure

6.3.1. Air Discharge:

This test is done on a non-conductive surface. The round discharge tip of the discharge electrode shall be approached as fast as possible to touch the EUT. After each discharge, the discharge electrode shall be removed from the EUT. The generator is then re-triggered for a new single discharge and repeated 10 times for each pre-selected test point. This procedure shall be repeated until all the air discharge completed.

6.3.2. Contact Discharge:

All the procedure shall be same as air discharge. Except that the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.

6.3.3. Indirect discharge for horizontal coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied at the front edge of each HCP opposite the center point of each unit (if applicable) of the EUT and 0.1m from the front of the EUT. The long axis of the discharge electrode shall be in the plane of the HCP and perpendicular to its front edge during the discharge.

6.3.4. Indirect discharge for vertical coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, is placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges shall be applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are completely illuminated.

6.4. Test Data

Please refer to the following pages.

Electrostatic Discharge Test Result

EUT	: <u>Solar Charger</u>	M/N	: <u>D5</u>
Temperature	: <u>22°C</u>	Humidity	: <u>50%</u>
Power supply	: <u>DC 5V</u>	Test Mode	: <u>Normal</u>
Criterion: B			
Air Discharge: $\pm 8\text{kV}$ Contact Discharge: $\pm 4\text{kV}$			
For each point positive 10 times and negative 10 times discharge.			
Location	Kind A-Air Discharge C-Contact Discharge	Result	
Nonconductive Enclosure	A	PASS	
Slot of the EUT	A	PASS	
USB Port	A	PASS	
LED Light	A	PASS	
HCP	C	PASS	
VCP of front	C	PASS	
VCP of rear	C	PASS	
VCP of left	C	PASS	
VCP of right	C	PASS	

7. Radiated Electromagnetic Field Immunity Test

7.1. Test Requirements

7.1.1. Test Standard

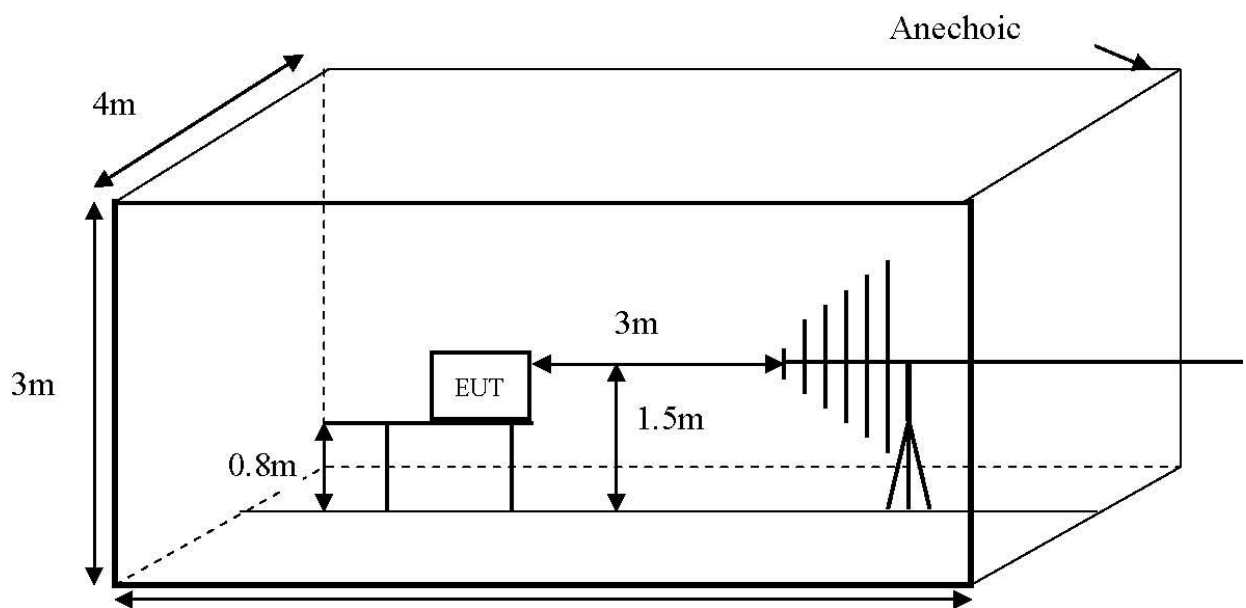
EN 55035:2017/A11:2020 (EN IEC 61000-4-3:2020)

7.1.2. Test Level

Level	Field Strength V/m
1	1
2	3
3	10
X	Special

7.1.3. Performance criterion: **A**

7.2. Test Setup



7.3. Test Procedure

The EUT are placed on a table, which is 0.8 meter high above the ground. The EUT is set 3 meters away from the transmitting antenna, which is mounted on an antenna tower. Both horizontal and vertical polarization of the antenna is set on test. Each of the four sides of the EUT must be faced this transmitting antenna and measured individually.

In order to judge the EUT performance, a camera is used to monitor its screen.

All the scanning conditions are as following:

Condition of Test	Remark
Fielded strength	3V/m (Severity Level 2)
Radiated signal	Modulated
Scanning frequency	80-1000MHz
Sweep time of radiated	0.0015 Decade/s
Dwell time	1 Sec.

7.4. Test Data

Please refer to the following pages.

RF Field Strength Susceptibility Test Results

EUT : <u>Solar Charger</u> M/N : <u>D5</u>				
Temperature : <u>22°C</u> Humidity : <u>50%</u>				
Power supply : <u>DC 5V</u> Test Mode : <u>Normal</u>				
Criterion: A				
Modulation: Unmodulated				
Pulse: AM 1KHz 80%				
	Frequency Range 1		Frequency Range 2	
	80~1000MHz			
	Horizontal	Vertical	Horizontal	Vertical
Front	PASS	PASS	/	/
Right	PASS	PASS	/	/
Rear	PASS	PASS	/	/
Left	PASS	PASS	/	/
Remark:				

8. Photographs - Constructional Details

Photo 1 Appearance of EUT

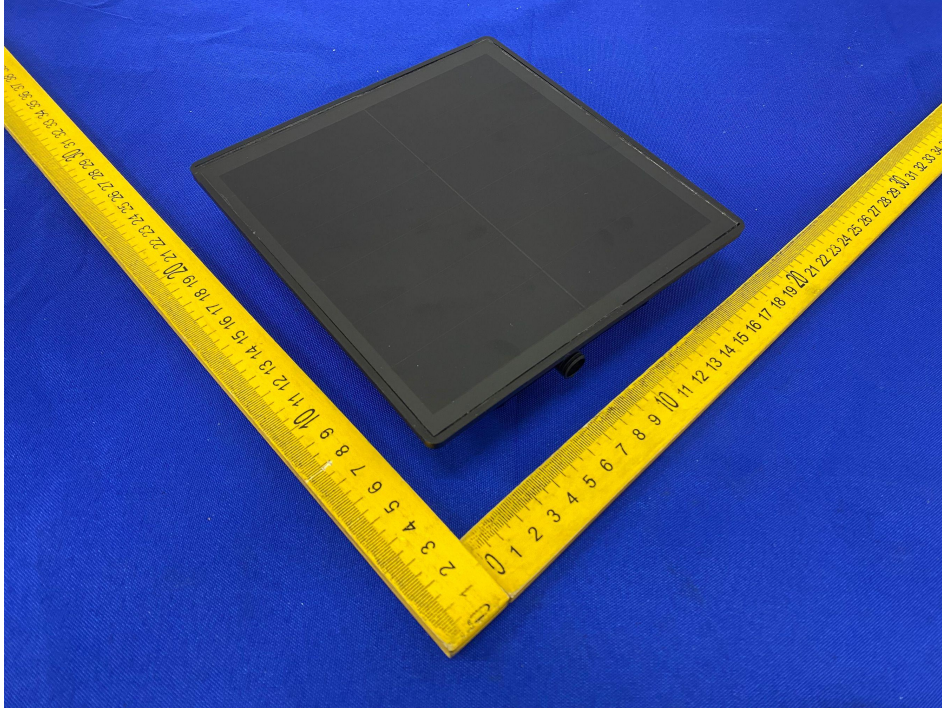


Photo 2 Appearance of EUT

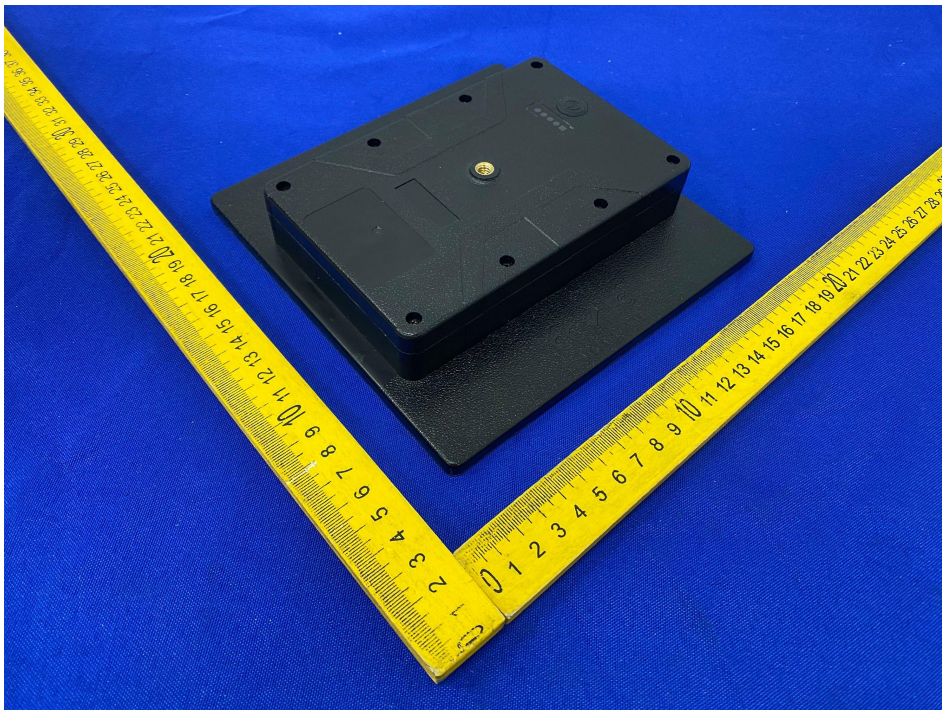


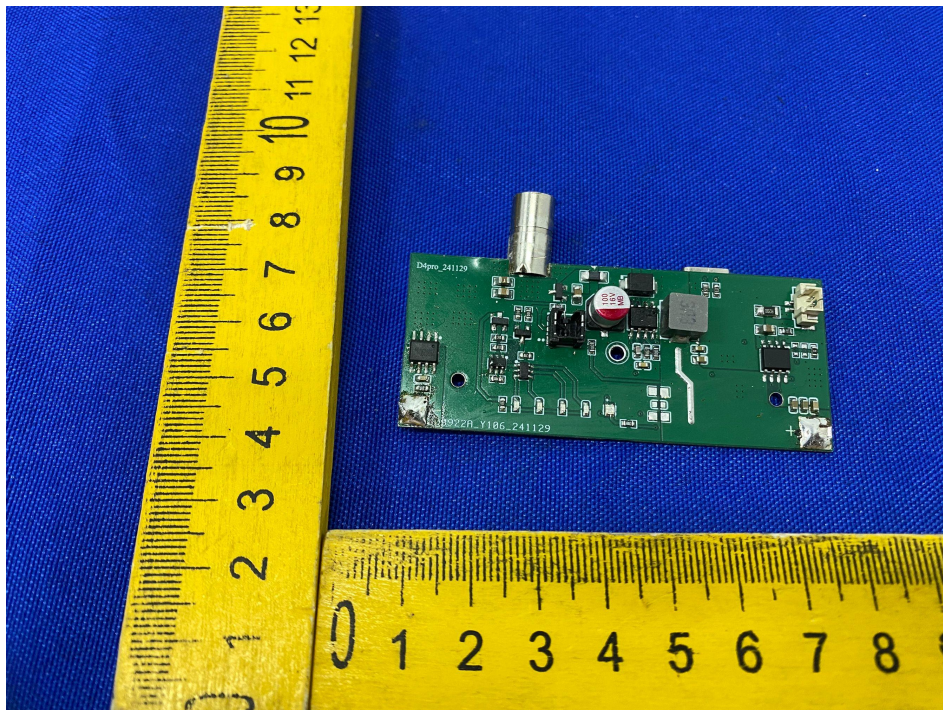
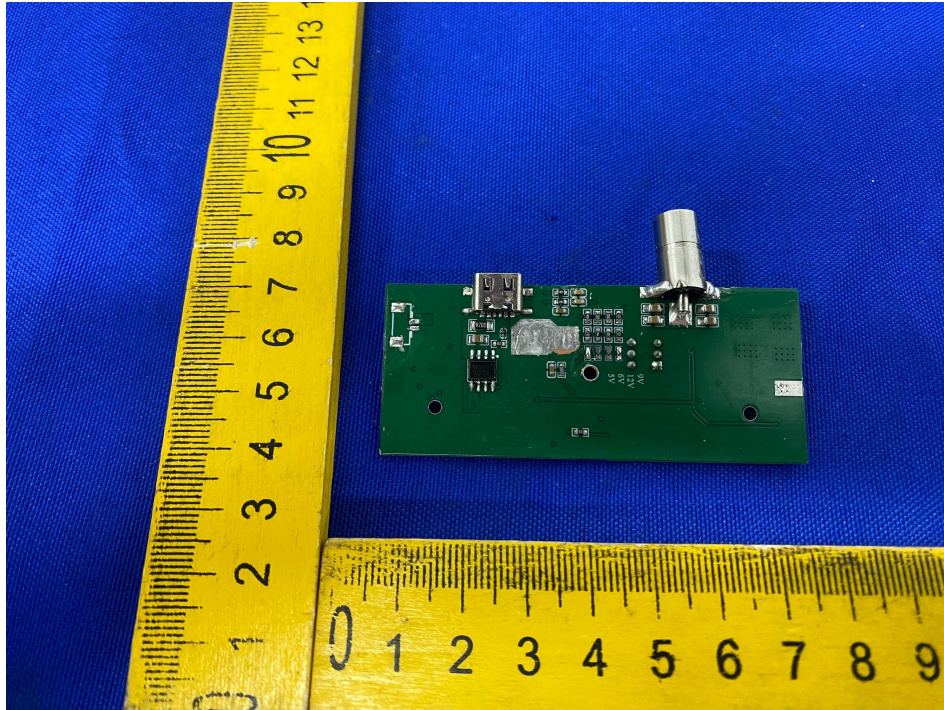
Photo 3 Inside of EUT**Photo 4 Appearance of PCB**

Photo 5 Appearance of PCB



END OF REPORT